

## ISL22416

Single Digitally Controlled Potentiometer (XDCP™) Low Noise, Low Power, SPI® Bus, 128 Taps

FN6227  
 Rev 2.00  
 September 9, 2009

The ISL22416 integrates a single digitally controlled potentiometer (DCP) and non-volatile memory on a monolithic CMOS integrated circuit.

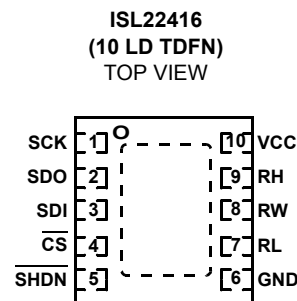
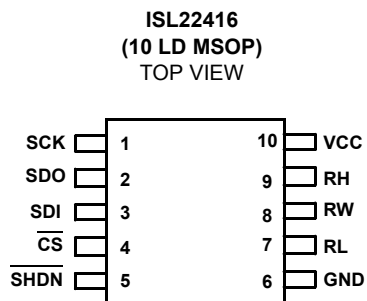
The digitally controlled potentiometer is implemented with a combination of resistor elements and CMOS switches. The position of the wiper is controlled by the user through the SPI serial interface. The potentiometer has an associated volatile Wiper Register (WR) and a non-volatile Initial Value Register (IVR) that can be directly written to and read by the user. The contents of the WR controls the position of the wiper. At power-up, the device recalls the contents of the DCP's IVR to the WR.

The DCP can be used as a three-terminal potentiometer or as a two-terminal variable resistor in a wide variety of applications including control, parameter adjustments, and signal processing.

### Features

- 128 resistor taps
- SPI serial interface
- Non-volatile storage of wiper position
- Wiper resistance: 70Ω typical @ V<sub>CC</sub> = 3.3V
- Shutdown mode
- Shutdown current 5μA max
- Power supply: 2.7V to 5.5V
- 50kΩ or 10kΩ total resistance
- High reliability
  - Endurance: 1,000,000 data changes per bit per register
  - Register data retention: 50 years @ T ≤ +55°C
- 10 Ld MSOP and 10 Ld TDFN package
- Pb-free (RoHS compliant)

### Pinout



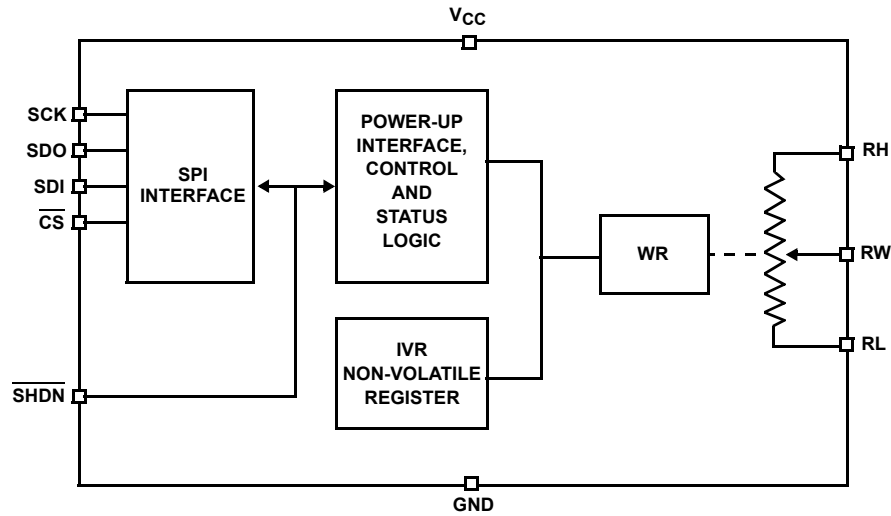
### Ordering Information

PART NUMBER (Note)	PART MARKING	RESISTANCE OPTION (kΩ)	TEMP. RANGE (°C)	PACKAGE (Pb-free)	PKG. DWG. #
ISL22416UFU10Z*	416UZ	50	-40 to +125	10 Ld MSOP	M10.118
ISL22416UFRT10Z*	416U	50	-40 to +125	10 Ld 3x3 TDFN	L10.3x3B
ISL22416WFU10Z*	416WZ	10	-40 to +125	10 Ld MSOP	M10.118
ISL22416WFRT10Z*	416W	10	-40 to +125	10 Ld 3x3 TDFN	L10.3x3B

\*Add "-TK" suffix for tape and reel. Please refer to TB347 for details on reel specifications.

NOTE: These Intersil Pb-free plastic packaged products employ special Pb-free material sets, molding compounds/die attach materials, and 100% matte tin plate plus anneal (e3 termination finish, which is RoHS compliant and compatible with both SnPb and Pb-free soldering operations). Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

## Block Diagram



## Pin Descriptions

MSOP/TDFN PIN NUMBER	SYMBOL	DESCRIPTION
1	SCK	SPI interface clock input
2	SDO	Push-pull/Open Drain Data Output of the SPI serial interface
3	SDI	Data Input of the SPI serial interface
4	$\overline{\text{CS}}$	Chip Select active low input
5	$\overline{\text{SHDN}}$	Shutdown active low input
6	GND	Device ground pin
7	RL	"Low" terminal of DCP
8	RW	"Wiper" terminal of DCP
9	RH	"High" terminal of DCP
10	V <sub>CC</sub>	Power supply pin

**Absolute Maximum Ratings**

Storage Temperature	-65°C to +150°C
Voltage at any Digital Interface Pin with Respect to GND	-0.3V to $V_{CC}+0.3$
$V_{CC}$	-0.3V to +6V
Voltage at any DCP pin with Respect to GND	-0.3V to $V_{CC}$
$I_W$ (10s)	±6mA
Latchup (Note 1)	Class II, Level B @ +125°C
ESD	
Human Body Model	5kV
Charge Device Model	1kV

**Thermal Information**

Thermal Resistance (Typical)	$\theta_{JA}$ (°C/W)	$\theta_{JC}$ (°C/W)
10 Lead MSOP (Note 2)	162	N/A
10 Lead TDFN (Notes 2, 3)	74	7
Maximum Junction Temperature (Plastic Package)	+150°C	
Pb-free reflow profile	see link below <a href="http://www.intersil.com/pbfree/Pb-FreeReflow.asp">http://www.intersil.com/pbfree/Pb-FreeReflow.asp</a>	

**Recommended Operating Conditions**

Temperature Range (Extended Industrial)	-40°C to +125°C
Power Rating	5mW
$V_{CC}$	2.7V to 5.5V
Wiper Current	±3.0mA

**CAUTION:** Do not operate at or near the maximum ratings listed for extended periods of time. Exposure to such conditions may adversely impact product reliability and result in failures not covered by warranty.

**NOTES:**

- Jedec Class II pulse conditions and failure criterion used. Level B exceptions are: using a max positive pulse of 6.5V on the SHDN pin, and using a max negative pulse of -1V for all pins.
- $\theta_{JA}$  is measured in free air with the component mounted on a high effective thermal conductivity test board with "direct attach" features. See Tech Brief TB379.
- For  $\theta_{JC}$ , the "case temp" location is the center of the exposed metal pad on the package underside.

**Analog Specifications**

Over recommended operating conditions, unless otherwise stated. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP (Note 4)	MAX	UNIT
$R_{TOTAL}$	$R_H$ to $R_L$ Resistance	W option		10		k $\Omega$
		U option		50		k $\Omega$
	$R_H$ to $R_L$ Resistance Tolerance	W and U option	-20		+20	%
	End-to-End Temperature Coefficient	W option			±50	
U option				±80		ppm/°C (Note 18)
$R_W$	Wiper Resistance	$V_{CC} = 3.3V$ , wiper current = $V_{CC}/R_{TOTAL}$		70	200	$\Omega$
$V_{RH}$ , $V_{RL}$	$V_{RH}$ and $V_{RL}$ Terminal Voltages	$V_{RH}$ and $V_{RL}$ to GND	0		$V_{CC}$	V
$C_H/C_L/C_W$ (Note 18)	Potentiometer Capacitance			10/10/25		pF
$I_{LkgDCP}$	Leakage on DCP Pins	Voltage at pin from GND to $V_{CC}$		0.1	1	$\mu A$
<b>VOLTAGE DIVIDER MODE (0V @ <math>R_L</math>; <math>V_{CC}</math> @ <math>R_H</math>; measured at <math>R_W</math>, unloaded)</b>						
INL (Note 9)	Integral Non-linearity	Monotonic over all tap positions, W and U option	-1		1	LSB (Note 5)
DNL (Note 8)	Differential Non-linearity	Monotonic over all tap positions, W and U option	-0.5		0.5	LSB (Note 5)
ZSerror (Note 6)	Zero-scale Error	W option	0	1	5	LSB (Note 5)
		U option	0	0.5	2	
FSerror (Note 7)	Full-scale Error	W option	-5	-1	0	LSB (Note 5)
		U option	-2	-1	0	
$TC_V$ (Note 10, 18)	Ratiometric Temperature Coefficient	DCP register set to 40 hex for W and U option		±4		ppm/°C

**Analog Specifications** Over recommended operating conditions, unless otherwise stated. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested. **(Continued)**

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP (Note 4)	MAX	UNIT
<b>RESISTOR MODE</b> (Measurements between $R_W$ and $R_L$ with $R_H$ not connected, or between $R_W$ and $R_H$ with $R_L$ not connected)						
RINL (Note 14)	Integral Non-linearity	DCP register set between 10 hex and 7F hex; monotonic over all tap positions; W and U option	-1		1	MI (Note 11)
RDNL (Note 13)	Differential Non-linearity	W option	-1		1	MI (Note 11)
		U option	-0.5		0.5	MI (Note 11)
Roffset (Note 12)	Offset	W option	0	1	5	MI (Note 11)
		U option	0	0.5	2	MI (Note 11)

**Operating Specifications** Over the recommended operating conditions, unless otherwise specified. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested.

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP (Note 4)	MAX	UNIT
$I_{CC1}$	$V_{CC}$ Supply Current (Volatile Write/Read)	$f_{SCK} = 5\text{MHz}$ ; (for SPI Active, Read and Volatile Write states only)			0.5	mA
$I_{CC2}$	$V_{CC}$ Supply Current (Non-volatile Write/Read)	$f_{SCK} = 5\text{MHz}$ ; (for SPI Active, Read and Non-volatile Write states only)			3	mA
$I_{SB}$	$V_{CC}$ Current (Standby)	$V_{CC} = +5.5\text{V}$ @ +85°C, SPI interface in standby state			5	$\mu\text{A}$
		$V_{CC} = +5.5\text{V}$ @ +125°C, SPI interface in standby state			7	$\mu\text{A}$
		$V_{CC} = +3.6\text{V}$ @ +85°C, SPI interface in standby state			3	$\mu\text{A}$
		$V_{CC} = +3.6\text{V}$ @ +125°C, SPI interface in standby state			5	$\mu\text{A}$
$I_{SD}$	$V_{CC}$ Current (Shutdown)	$V_{CC} = +5.5\text{V}$ @ +85°C, SPI interface in standby state			3	$\mu\text{A}$
		$V_{CC} = +5.5\text{V}$ @ +125°C, SPI interface in standby state			5	$\mu\text{A}$
		$V_{CC} = +3.6\text{V}$ @ +85°C, SPI interface in standby state			2	$\mu\text{A}$
		$V_{CC} = +3.6\text{V}$ @ +125°C, SPI interface in standby state			4	$\mu\text{A}$
$I_{LkgDig}$	Leakage Current, at Pins $\overline{\text{SHDN}}$ , SCK, SDI, SDO and $\overline{\text{CS}}$	Voltage at pin from GND to $V_{CC}$ , SDO is inactive	-1		1	$\mu\text{A}$
$t_{WRT}$ (Note 18)	Wiper Response Time	Wiper Response Time after SPI write to WR register		1.5		$\mu\text{s}$
$t_{ShdnRec}$ (Note 18)	DCP Recall Time from Shutdown Mode	From rising edge of $\overline{\text{SHDN}}$ signal to wiper stored position and RH connection		1.5		$\mu\text{s}$
		SCK rising edge of last bit of ACR data byte to wiper stored position and RH connection		1.5		$\mu\text{s}$
$V_{POR}$	Power-on Recall Voltage	Minimum $V_{CC}$ at which memory recall occurs	2.0		2.6	V
$V_{CC}$ Ramp	$V_{CC}$ Ramp Rate		0.2			V/ms

**Operating Specifications** Over the recommended operating conditions, unless otherwise specified. Parameters with MIN and/or MAX limits are 100% tested at +25°C, unless otherwise specified. Temperature limits established by characterization and are not production tested. **(Continued)**

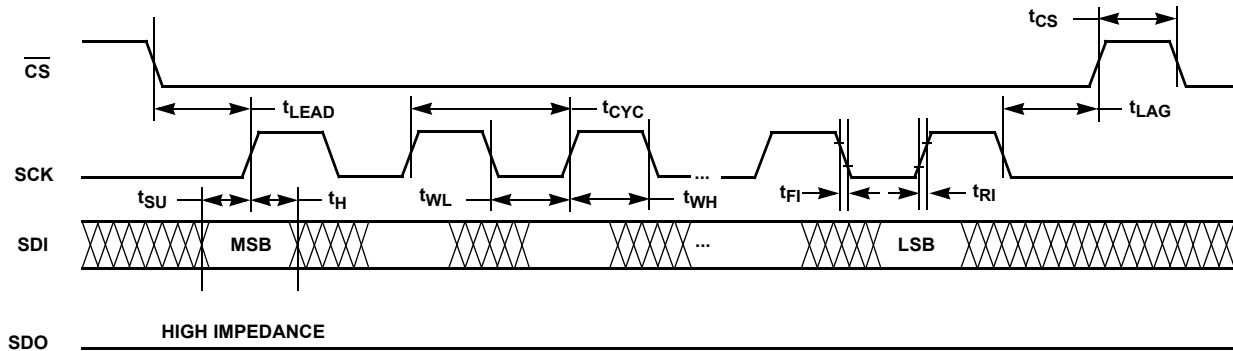
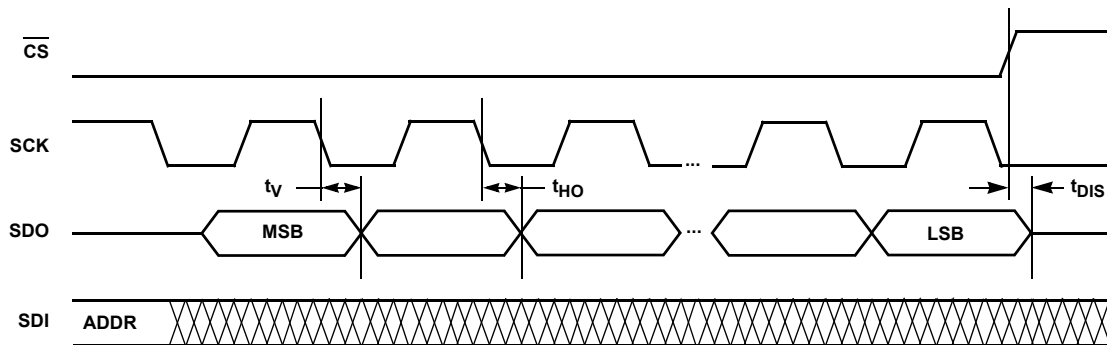
SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP (Note 4)	MAX	UNIT
$t_D$	Power-up Delay	$V_{CC}$ above $V_{POR}$ , to DCP Initial Value Register recall completed, and SPI Interface in standby state			3	ms
<b>EEPROM SPECIFICATION</b>						
	EEPROM Endurance		1,000,000			Cycles
	EEPROM Retention	Temperature $T \leq +55^\circ\text{C}$	50			Years
$t_{WC}$ (Note 16)	Non-volatile Write Cycle Time			12	20	ms
<b>SERIAL INTERFACE SPECIFICATIONS</b>						
$V_{IL}$	$\overline{\text{SHDN}}$ , SCK, SDI, and $\overline{\text{CS}}$ Input Buffer LOW Voltage		-0.3		$0.3 \cdot V_{CC}$	V
$V_{IH}$	$\overline{\text{SHDN}}$ , SCK, SDI, and $\overline{\text{CS}}$ Input Buffer HIGH Voltage		$0.7 \cdot V_{CC}$		$V_{CC} + 0.3$	V
Hysteresis	$\overline{\text{SHDN}}$ , SCK, SDI, and $\overline{\text{CS}}$ Input Buffer Hysteresis		$0.05 \cdot V_{CC}$			V
$V_{OL}$	SDO Output Buffer LOW Voltage	$I_{OL} = 4\text{mA}$	0		0.4	V
$R_{pu}$ (Note 17)	SDO Pull-up Resistor Off-chip	Maximum is determined by $t_{RO}$ and $t_{FO}$ with maximum bus load $C_b = 30\text{pF}$ , $f_{SCK} = 5\text{MHz}$			2	$k\Omega$
$C_{pin}$ (Note 18)	$\overline{\text{SHDN}}$ , SCK, SDI, SDO and $\overline{\text{CS}}$ Pin Capacitance				10	pF
$f_{SCK}$	SPI Frequency				5	MHz
$t_{CYC}$	SPI Clock Cycle Time		200			ns
$t_{WH}$	SPI Clock High Time		100			ns
$t_{WL}$	SPI Clock Low Time		100			ns
$t_{LEAD}$	Lead Time		250			ns
$t_{LAG}$	Lag Time		250			ns
$t_{SU}$	SDI, SCK and $\overline{\text{CS}}$ Input Setup Time		50			ns
$t_H$	SDI, SCK and $\overline{\text{CS}}$ Input Hold Time		50			ns
$t_{RI}$	SDI, SCK and $\overline{\text{CS}}$ Input Rise Time		10			ns
$t_{FI}$	SDI, SCK and $\overline{\text{CS}}$ Input Fall Time		10		20	ns
$t_{DIS}$	SDO Output Disable Time		0		100	ns
$t_V$	SDO Output Valid Time				350	ns
$t_{HO}$	SDO Output Hold Time		0			ns
$t_{RO}$	SDO Output Rise Time	$R_{pu} = 2k$ , $C_{bus} = 30\text{pF}$			60	ns
$t_{FO}$	SDO Output Fall Time	$R_{pu} = 2k$ , $C_{bus} = 30\text{pF}$			60	ns
$t_{CS}$	CS Deselect Time		2			$\mu\text{s}$

## NOTES:

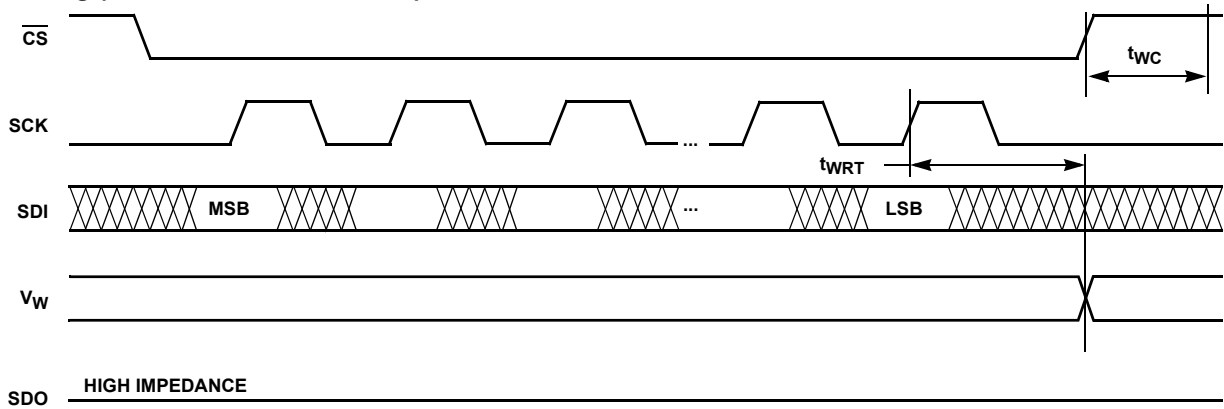
- Typical values are for  $T_A = +25^\circ\text{C}$  and 3.3V supply voltage.
- LSB:  $[V(RW)_{127} - V(RW)_0]/127$ .  $V(RW)_{127}$  and  $V(RW)_0$  are  $V(RW)$  for the DCP register set to 7F hex and 00 hex respectively. LSB is the incremental voltage when changing from one tap to an adjacent tap.
- ZS error =  $V(RW)_0/\text{LSB}$ .
- FS error =  $[V(RW)_{127} - V_{CC}]/\text{LSB}$ .

## NOTES: (Continued)

8.  $DNL = [V(RW)_i - V(RW)_{i-1}] / LSB - 1$ , for  $i = 1$  to 127.  $i$  is the DCP register setting.
9.  $INL = [V(RW)_i - (i \cdot LSB) - V(RW)_0] / LSB$  for  $i = 1$  to 127
10.  $TC_V = \frac{\text{Max}(V(RW)_i) - \text{Min}(V(RW)_i)}{[\text{Max}(V(RW)_i) + \text{Min}(V(RW)_i)] / 2} \times \frac{10^6}{+165^\circ\text{C}}$  for  $i = 16$  to 127 decimal,  $T = -40^\circ\text{C}$  to  $125^\circ\text{C}$ .  $\text{Max}()$  is the maximum value of the wiper voltage and  $\text{Min}()$  is the minimum value of the wiper voltage over the temperature range.
11.  $MI = |RW_{127} - RW_0| / 127$ .  $MI$  is a minimum increment.  $RW_{127}$  and  $RW_0$  are the measured resistances for the DCP register set to 7F hex and 00 hex respectively.
12.  $\text{Roffset} = RW_0 / MI$ , when measuring between  $RW$  and  $RL$ .  
 $\text{Roffset} = RW_{127} / MI$ , when measuring between  $RW$  and  $RH$ .
13.  $RDNL = (RW_i - RW_{i-1}) / MI - 1$ , for  $i = 1$  to 127.
14.  $RINL = [RW_i - (MI \cdot i) - RW_0] / MI$ , for  $i = 1$  to 127.
15.  $TC_R = \frac{[\text{Max}(R_i) - \text{Min}(R_i)]}{[\text{Max}(R_i) + \text{Min}(R_i)] / 2} \times \frac{10^6}{165^\circ\text{C}}$  for  $i = 16$  to 127,  $T = -40^\circ\text{C}$  to  $125^\circ\text{C}$ .  $\text{Max}()$  is the maximum value of the resistance and  $\text{Min}()$  is the minimum value of the resistance over the temperature range.
16.  $t_{WC}$  is the time from the end of a Write sequence of SPI serial interface, to the end of the self-timed internal non-volatile write cycle.
17.  $R_{PU}$  is specified for the highest data rate transfer for the device. Higher value pull-up can be used at lower data rates.
18. Limits should be considered typical and are not production tested.

**Timing Diagrams****Input Timing****Output Timing**

**XDCP Timing (for All Load Instructions)**



**Typical Performance Curves**

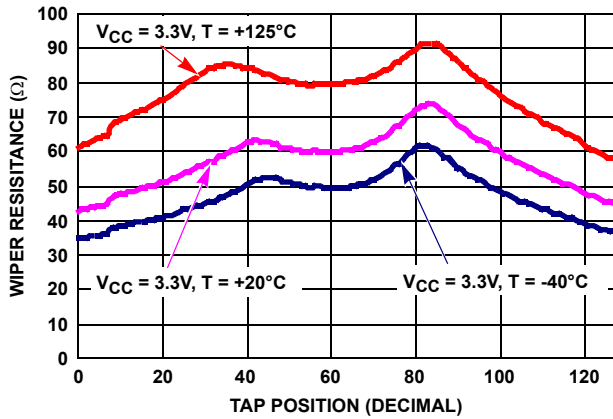


FIGURE 1. WIPER RESISTANCE vs TAP POSITION [  $I(RW) = V_{CC}/R_{TOTAL}$  ] FOR 10k $\Omega$  (W)

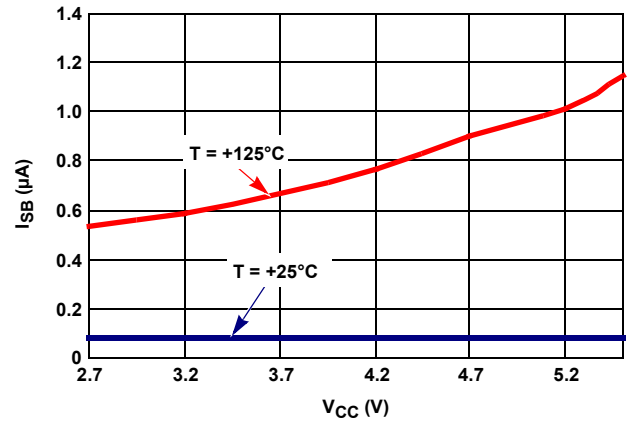


FIGURE 2. STANDBY  $I_{CC}$  vs  $V_{CC}$

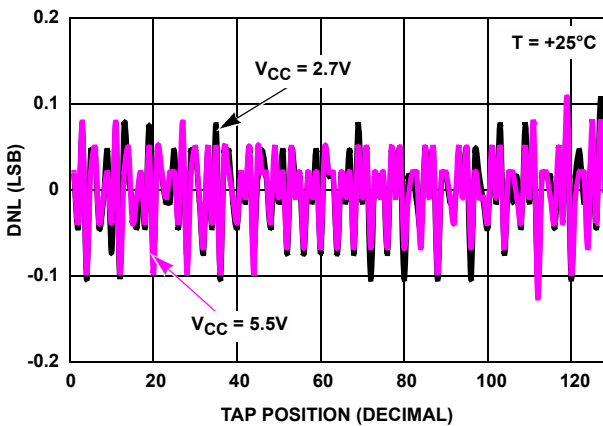


FIGURE 3. DNL vs TAP POSITION IN VOLTAGE DIVIDER MODE FOR 10k $\Omega$  (W)

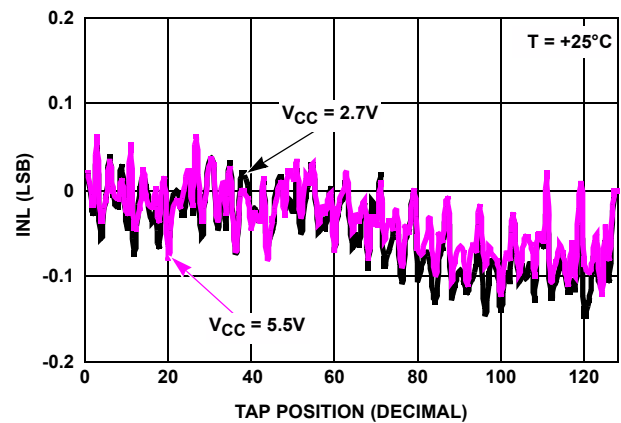


FIGURE 4. INL vs TAP POSITION IN VOLTAGE DIVIDER MODE FOR 10k $\Omega$  (W)

**Typical Performance Curves** (Continued)

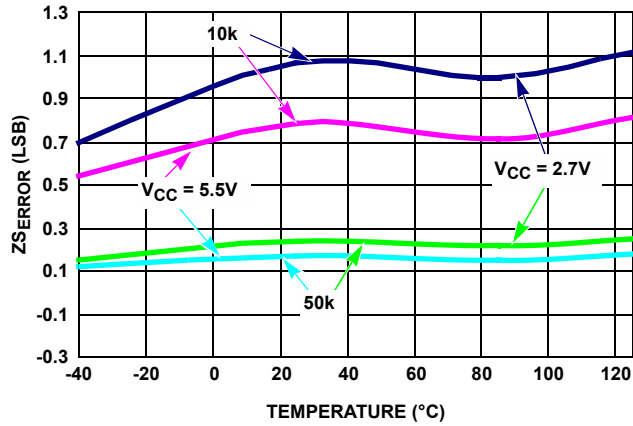


FIGURE 5. Z<sub>S</sub>ERROR vs TEMPERATURE

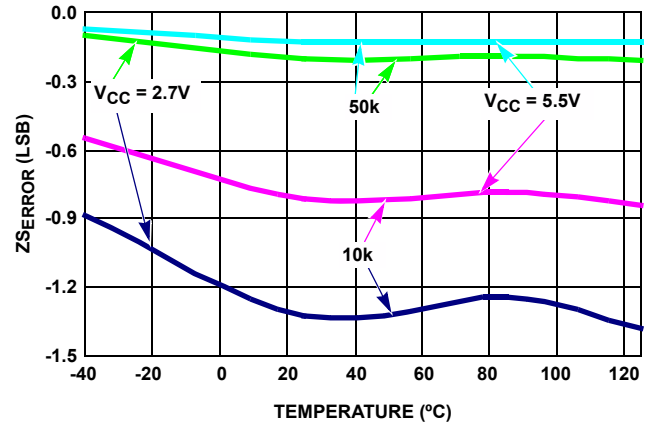


FIGURE 6. F<sub>S</sub>ERROR vs TEMPERATURE

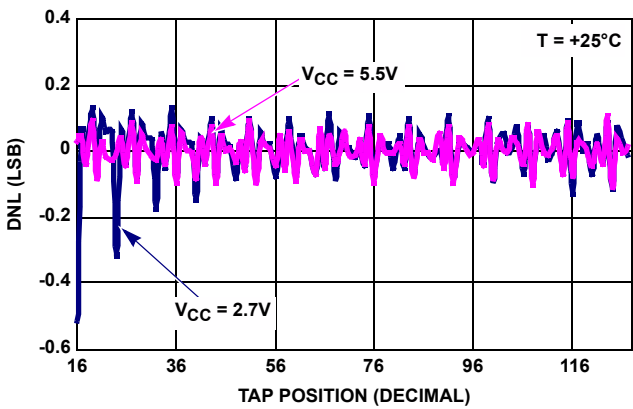


FIGURE 7. DNL vs TAP POSITION IN RHEOSTAT MODE FOR 10kΩ (W)

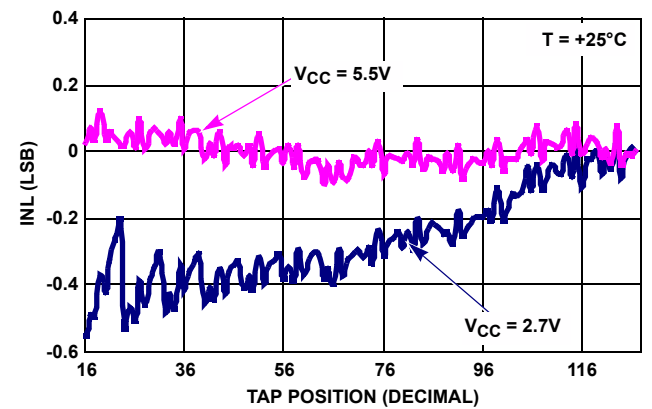


FIGURE 8. INL vs TAP POSITION IN RHEOSTAT MODE FOR 10kΩ (W)

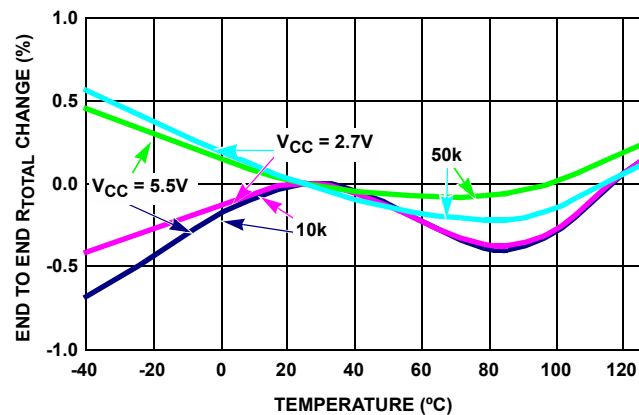


FIGURE 9. END TO END R<sub>TOTAL</sub> % CHANGE vs TEMPERATURE

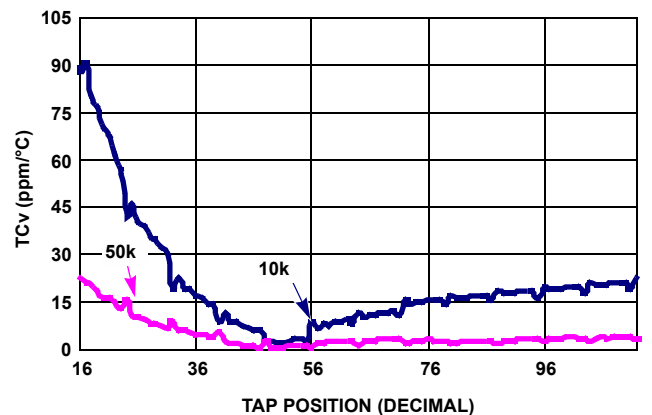


FIGURE 10. TC FOR VOLTAGE DIVIDER MODE IN ppm



**Typical Performance Curves** (Continued)

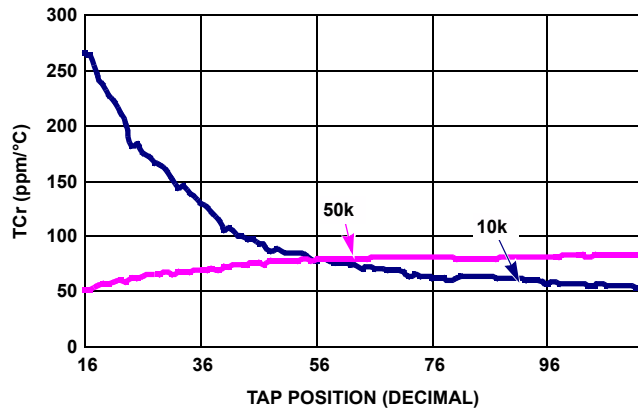


FIGURE 11. TC FOR RHEOSTAT MODE IN ppm

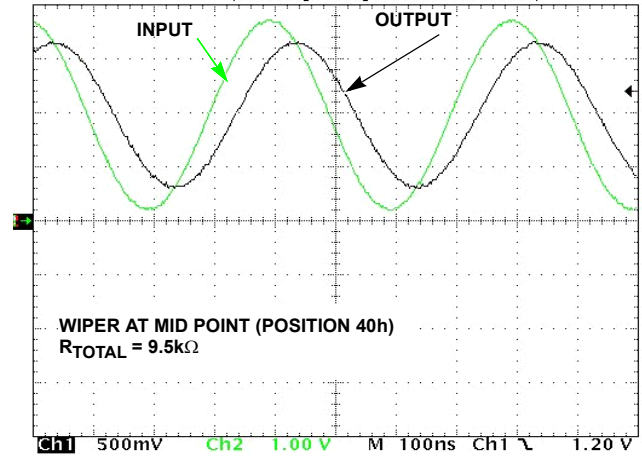


FIGURE 12. FREQUENCY RESPONSE (2.6MHz)

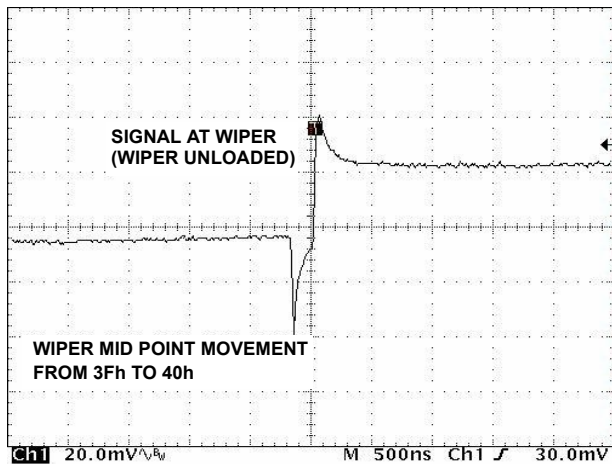


FIGURE 13. MIDSCALE GLITCH, CODE 3Fh TO 40h

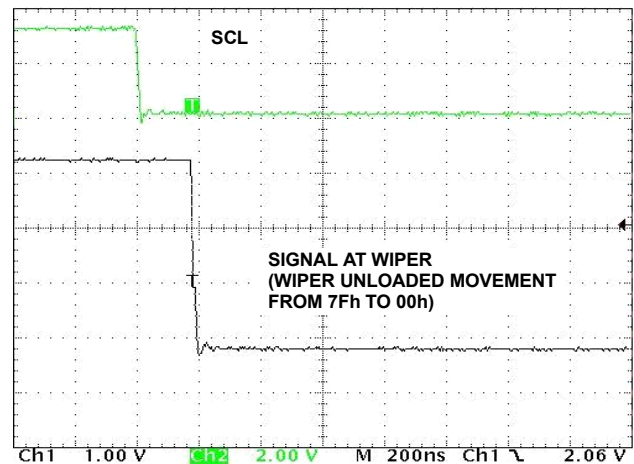


FIGURE 14. LARGE SIGNAL SETTLING TIME

**Pin Description**

**Potentiometer Pins**

**RH AND RL**

The high (RH) and low (RL) terminals of the ISL22416 are equivalent to the fixed terminals of a mechanical potentiometer. RH and RL are referenced to the relative position of the wiper and not the voltage potential on the terminals. With WR set to 127 decimal, the wiper will be closest to RH, and with the WR set to 0, the wiper is closest to RL.

**RW**

RW is the wiper terminal and is equivalent to the movable terminal of a mechanical potentiometer. The position of the wiper within the array is determined by the WR register.

**SHDN**

The SHDN pin forces the resistor to end-to-end open circuit condition on RH and shorts RW to RL. When SHDN is returned

to logic high, the previous latch settings put RW at the same resistance setting prior to shutdown. This pin is logically ANDed with SHDN bit in ACR register. SPI interface is still available in shutdown mode and all registers are accessible. This pin must remain HIGH for normal operation.

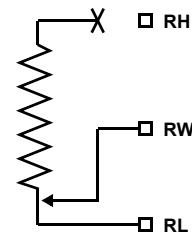


FIGURE 15. DCP CONNECTION IN SHUTDOWN MODE

## Bus Interface Pins

### SERIAL CLOCK (SCK)

This is the serial clock input of the SPI serial interface.

### SERIAL DATA OUTPUT (SDO)

The SDO is an open drain serial data output pin. During a read cycle, the data bits are shifted out at the falling edge of the serial clock SCK, while the  $\overline{CS}$  input is low.

SDO requires an external pull-up resistor for proper operation.

### SERIAL DATA INPUT (SDI)

The SDI is the serial data input pin for the SPI interface. It receives device address, operation code, wiper address and data from the SPI external host device. The data bits are shifted in at the rising edge of the serial clock SCK, while the  $\overline{CS}$  input is low.

### CHIP SELECT ( $\overline{CS}$ )

$\overline{CS}$  LOW enables the ISL22416, placing it in the active power mode. A HIGH to LOW transition on  $\overline{CS}$  is required prior to the start of any operation after power up. When  $\overline{CS}$  is HIGH, the ISL22416 is deselected and the SDO pin is at high impedance, and (unless an internal write cycle is underway) the device will be in the standby state.

## Principles of Operation

The ISL22416 is an integrated circuit incorporating one DCP with its associated registers, non-volatile memory and the SPI serial interface providing direct communication between host and potentiometer and memory. The resistor array is comprised of individual resistors connected in series. At either end of the array and between each resistor is an electronic switch that transfers the potential at that point to the wiper.

The electronic switches on the device operate in a “make before break” mode when the wiper changes tap positions.

When the device is powered down, the last value stored in IVR will be maintained in the non-volatile memory. When power is restored, the contents of the IVR is recalled and loaded into the WR to set the wiper to the initial value.

### DCP Description

The DCP is implemented with a combination of resistor elements and CMOS switches. The physical ends of each DCP are equivalent to the fixed terminals of a mechanical potentiometer (RH and RL pins). The RW pin of the DCP is connected to intermediate nodes, and is equivalent to the wiper terminal of a mechanical potentiometer. The position of the wiper terminal within the DCP is controlled by a 7-bit volatile Wiper Register (WR). When the WR of a DCP contains all zeroes (WR<6:0>: 00h), its wiper terminal (RW) is closest to its “Low” terminal (RL). When the WR register of a DCP contains all ones (WR<6:0>: 7Fh), its wiper terminal (RW) is closest to its “High” terminal (RH). As the value of the WR increases from all zeroes (0) to all ones (127 decimal), the wiper moves

monotonically from the position closest to RL to the closest to RH. At the same time, the resistance between RW and RL increases monotonically, while the resistance between RH and RW decreases monotonically.

While the ISL22416 is being powered up, the WR is reset to 40h (64 decimal), which locates RW roughly at the center between RL and RH. After the power supply voltage becomes large enough for reliable non-volatile memory reading, the WR will be reload with the value stored in a non-volatile Initial Value Register (IVR).

The WR and IVR can be read or written to directly using the SPI serial interface as described in the following sections.

### Memory Description

The ISL22416 contains one non-volatile 7-bit register, known as the Initial Value Register (IVR), volatile 7-bit Wiper Register (WR), and volatile 8-bit Access Control Register (ACR). The memory map is shown in Table 1. The non-volatile register (IVR) at address 0, contain initial wiper position and volatile registers (WR) contain current wiper position.

TABLE 1. MEMORY MAP

ADDRESS	NON-VOLATILE	VOLATILE
2	—	ACR
1	Reserved	
0	IVR	WR

The non-volatile IVR and volatile WR registers are accessible with the same address.

The Access Control Register (ACR) contains information and control bits described in Table 2.

The VOL bit (ACR<7>) determines whether the access is to wiper registers WR or initial value registers IVR.

TABLE 2. ACCESS CONTROL REGISTER (ACR)

BIT #	7	6	5	4	3	2	1	0
BIT NAME	VOL	SHDN	WIP	0	0	0	0	0

If VOL bit is 0, the non-volatile IVR register is accessible. If VOL bit is 1, only the volatile WR is accessible. Note, value is written to IVR register also is written to the WR. The default value of this bit is 0.

The SHDN bit (ACR<6>) disables or enables Shutdown mode. This bit is logically ANDed with  $\overline{SHDN}$  pin. When this bit is 0, DCP is in Shutdown mode. Default value of SHDN bit is 1.

The WIP bit (ACR<5>) is read only bit. It indicates that non-volatile write operation is in progress. The WIP bit can be read repeatedly after a non-volatile write to determine if the write has been completed. It is impossible to write to the WR or ACR while WIP bit is 1.

### Shutdown Mode

The device can be put in Shutdown mode either by pulling the  $\overline{\text{SHDN}}$  pin to GND or setting the SHDN bit in the ACR register to 0. The truth table for Shutdown mode is in Table 3.

TABLE 3. SHUTDOWN MODE

$\overline{\text{SHDN}}$ PIN	SHDN BIT	MODE
High	1	Normal operation
Low	1	Shutdown
High	0	Shutdown
Low	0	Shutdown

### SPI Serial Interface

The ISL22416 supports an SPI serial protocol, mode 0. The device is accessed via the SDI input and SDO output with data clocked in on the rising edge of SCK, and clocked out on the falling edge of SCK.  $\overline{\text{CS}}$  must be LOW during communication with the ISL22416. SCK and  $\overline{\text{CS}}$  lines are controlled by the host or master. The ISL22416 operates only as a slave device.

All communication over the SPI interface is conducted by sending the MSB of each byte of data first.

### Protocol Conventions

The first byte sent to the ISL22416 from the SPI host is the Identification Byte. A valid Identification Byte contains 0101 as the four MSBs, with the following four bits set to 0.

TABLE 4. IDENTIFICATION BYTE FORMAT

0	1	0	1	0	0	0	0
(MSB)							(LSB)

The next byte sent to the ISL22416 contains the instruction and register pointer information. The four MSBs are the instruction and two LSBs are register address (see Table 5).

TABLE 5. IDENTIFICATION BYTE FORMAT

7	6	5	4	3	2	1	0
I3	I2	I1	I0	0	0	R1	R0

There are only two valid instruction sets:

1011(binary) - is a Read operation

1100(binary) - is a Write operation

There are only two registers address possible for this DCP. If the R1, R0 bits are zero, then the read or write is to either the IVR or the WR register (depends of VOL bit at ACR). If the R1 bit is 1 and R0 bit is 0, then the operation is on the ACR.

### Write Operation

A Write operation to the ISL22416 is a three-byte operation. It requires first, the  $\overline{\text{CS}}$  transition from HIGH to LOW, then a valid Identification Byte, then a valid instruction byte followed by Data Byte is sent to SDI pin. The host terminates the write

operation by pulling the  $\overline{\text{CS}}$  pin from LOW to HIGH. For a write to address 0 (WR), the byte at address 2 (ACR<7>) determines if the Data Byte is to be written to volatile or both volatile and non-volatile registers. Refer to "Memory Description" on page 10 and Figure 16.

The internal non-volatile write cycle starts after rising edge of  $\overline{\text{CS}}$  and takes up to 20ms.

### Read Operation

A read operation to the ISL22416 is a three byte operation. It requires first, the  $\overline{\text{CS}}$  transition from HIGH to LOW, then a valid Identification Byte, then a valid instruction byte followed by "dummy" Data Byte is sent to SDI pin. The SPI host reads the data from SDO pin on falling edge of SCK. The host terminates the read operation by pulling the  $\overline{\text{CS}}$  pin from LOW to HIGH (see Figure 17).

In order to read back the non-volatile IVR, it is recommended that the application reads the ACR first to verify the WIP bit is 0. If the WIP bit (ACR[5]) is not 0, the host should repeat its reading sequence again.

## Applications Information

### Communicating with ISL22416

Communication with ISL22416 proceeds using SPI interface through the ACR (address 10b), IVR (address 00b) and WR (address 00b) registers.

The wiper of the potentiometer is controlled by the WR register. Writes and reads can be made directly to this register to control and monitor the wiper position without any non-volatile memory changes. This is done by setting MSB bit at address 10b to 1.

The non-volatile IVR stores the power up value of the wiper. IVR is accessible when MSB bit at address 10b is set to 0. Writing a new value to the IVR register will set a new power up position for the wiper. Also, writing to this register will load the same value into the WR as the IVR. Reading from the IVR will not change the WR, if its contents are different.

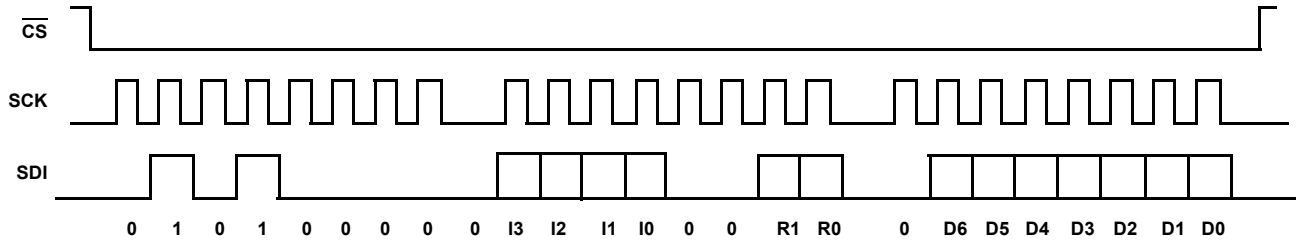


FIGURE 16. THREE BYTE WRITE SEQUENCE

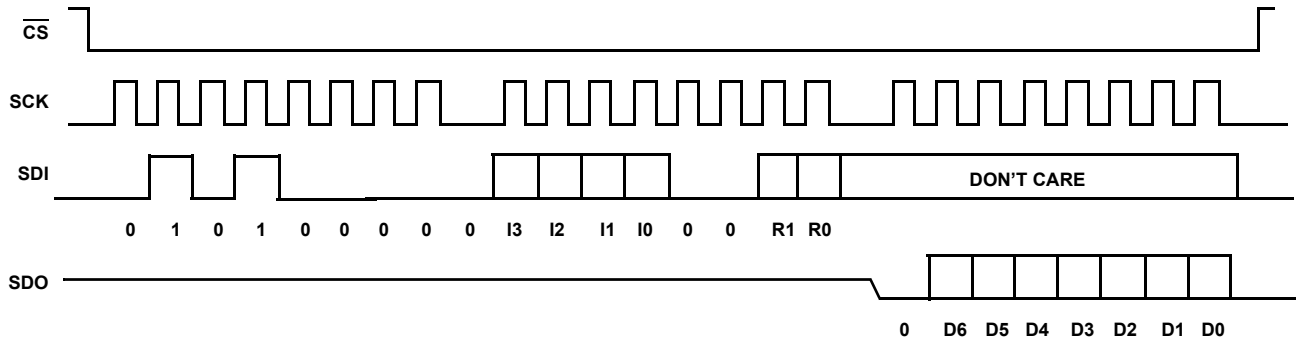


FIGURE 17. THREE BYTE READ SEQUENCE

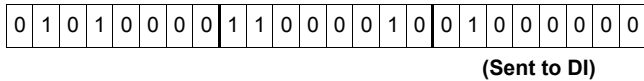
**Examples**

**A. Writing to the IVR**

This sequence will write a new value (77h) to the IVR (non-volatile):

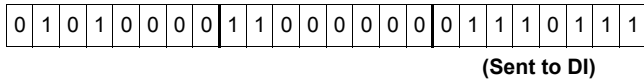
Set the ACR (Addr 02h) for NV write (40h)

Send the ID byte, Instruction Byte, then the Data byte



Set the IVR (Addr 00h) to 77h

Send the ID byte, Instruction Byte, then the Data byte

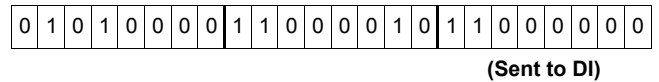


**B. Reading from the WR**

This sequence will read the value from the WR (volatile):

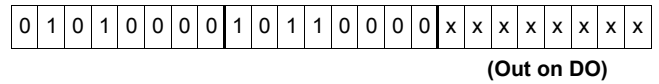
Write to ACR first to access the WR

Send the ID byte, Instruction Byte, then the Data byte

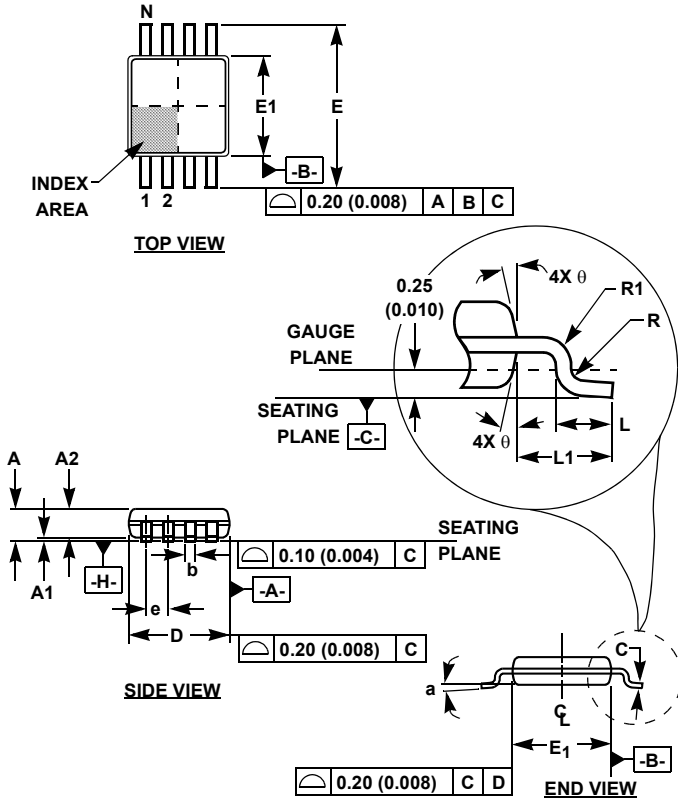


Read the data from WR (Addr 00h)

Send the ID byte, Instruction Byte, then Read the Data byte



**Mini Small Outline Plastic Packages (MSOP)**



**M10.118 (JEDEC MO-187BA)**  
**10 LEAD MINI SMALL OUTLINE PLASTIC PACKAGE**

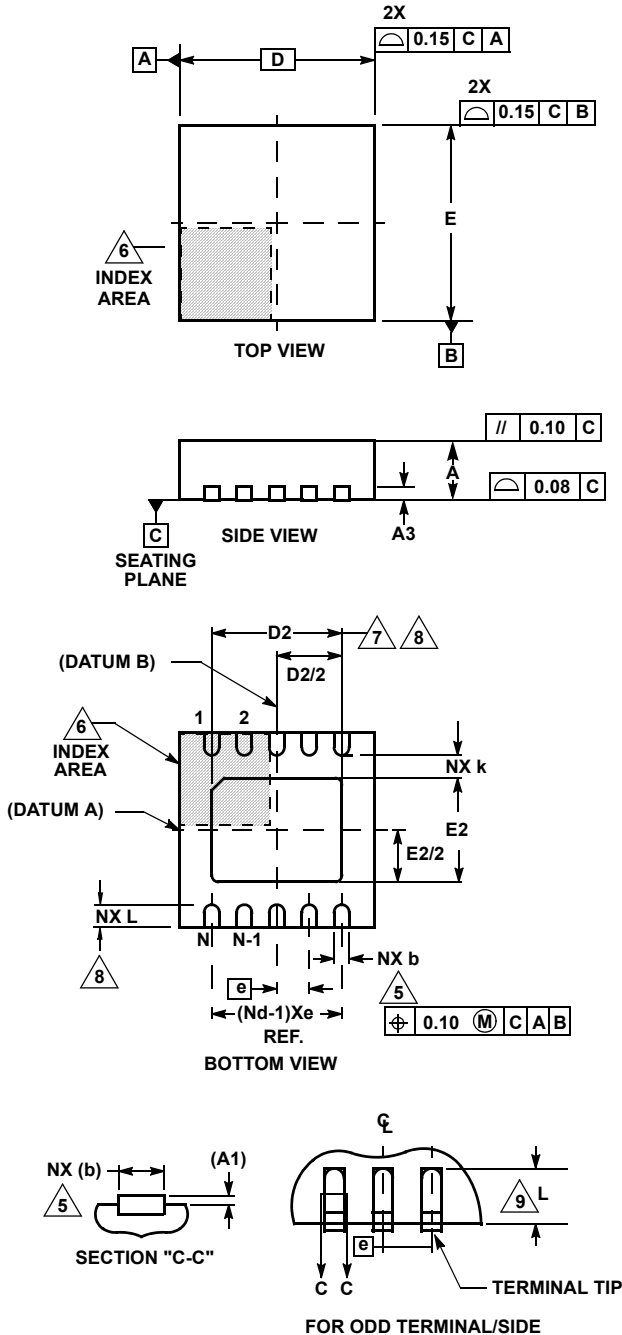
SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.037	0.043	0.94	1.10	-
A1	0.002	0.006	0.05	0.15	-
A2	0.030	0.037	0.75	0.95	-
b	0.007	0.011	0.18	0.27	9
c	0.004	0.008	0.09	0.20	-
D	0.116	0.120	2.95	3.05	3
E1	0.116	0.120	2.95	3.05	4
e	0.020 BSC		0.50 BSC		-
E	0.187	0.199	4.75	5.05	-
L	0.016	0.028	0.40	0.70	6
L1	0.037 REF		0.95 REF		-
N	10		10		7
R	0.003	-	0.07	-	-
R1	0.003	-	0.07	-	-
θ	5°	15°	5°	15°	-
α	0°	6°	0°	6°	-

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**NOTES:**

1. These package dimensions are within allowable dimensions of JEDEC MO-187BA.
2. Dimensioning and tolerancing per ANSI Y14.5M-1994.
3. Dimension "D" does not include mold flash, protrusions or gate burrs and are measured at Datum Plane. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
4. Dimension "E1" does not include interlead flash or protrusions and are measured at Datum Plane. [-H-] Interlead flash and protrusions shall not exceed 0.15mm (0.006 inch) per side.
5. Formed leads shall be planar with respect to one another within 0.10mm (.004) at seating Plane.
6. "L" is the length of terminal for soldering to a substrate.
7. "N" is the number of terminal positions.
8. Terminal numbers are shown for reference only.
9. Dimension "b" does not include dambar protrusion. Allowable dambar protrusion shall be 0.08mm (0.003 inch) total in excess of "b" dimension at maximum material condition. Minimum space between protrusion and adjacent lead is 0.07mm (0.0027 inch).
10. Datums [-A-] and [-B-] to be determined at Datum plane [-H-].
11. Controlling dimension: MILLIMETER. Converted inch dimensions are for reference only

**Thin Dual Flat No-Lead Plastic Package (TDFN)**



**L10.3x3B**

**10 LEAD THIN DUAL FLAT NO-LEAD PLASTIC PACKAGE**

SYMBOL	MILLIMETERS			NOTES
	MIN	NOMINAL	MAX	
A	0.70	0.75	0.80	-
A1	-	-	0.05	-
A3	0.20 REF			-
b	0.18	0.25	0.30	5, 8
D	3.00 BSC			-
D2	2.23	2.38	2.48	7, 8
E	3.00 BSC			-
E2	1.49	1.64	1.74	7, 8
e	0.50 BSC			-
k	0.20	-	-	-
L	0.30	0.40	0.50	8
N	10			2
Nd	5			3

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**NOTES:**

1. Dimensioning and tolerancing conform to ASME Y14.5-1994.
2. N is the number of terminals.
3. Nd refers to the number of terminals on D.
4. All dimensions are in millimeters. Angles are in degrees.
5. Dimension b applies to the metallized terminal and is measured between 0.15mm and 0.30mm from the terminal tip.
6. The configuration of the pin #1 identifier is optional, but must be located within the zone indicated. The pin #1 identifier may be either a mold or mark feature.
7. Dimensions D2 and E2 are for the exposed pads which provide improved electrical and thermal performance.
8. Nominal dimensions are provided to assist with PCB Land Pattern Design efforts, see Intersil Technical Brief TB389.
9. COMPLIANT TO JEDEC MO-229-WEED-3 except for dimensions E2 & D2.

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